

Series T491  Dielectric MnO2 Tantalum  Style SMD Chip  Description SMD, MnO2, Molded  RoHS Yes  Termination Tin  AEC-Q200 No  Typical Component Weight 224.48 mg  Shelf Life 156 Weeks	General Information	
Style SMD Chip  Description SMD, MnO2, Molded  RoHS Yes  Termination Tin  AEC-Q200 No  Typical Component Weight 224.48 mg  Shelf Life 156 Weeks	Series	T491
Description SMD, MnO2, Molded RoHS Yes Termination Tin AEC-Q200 No Typical Component Weight 224.48 mg Shelf Life 156 Weeks	Dielectric	MnO2 Tantalum
RoHS Yes  Termination Tin  AEC-Q200 No  Typical Component Weight 224.48 mg  Shelf Life 156 Weeks	Style	SMD Chip
Termination Tin  AEC-Q200 No  Typical Component Weight 224.48 mg  Shelf Life 156 Weeks	Description	SMD, MnO2, Molded
AEC-Q200 No Typical Component Weight 224.48 mg Shelf Life 156 Weeks	RoHS	Yes
Typical Component Weight 224.48 mg Shelf Life 156 Weeks	Termination	Tin
Shelf Life 156 Weeks	AEC-Q200	No
	Typical Component Weight	224.48 mg
MCI 1	Shelf Life	156 Weeks
IVIOL	MSL	1

Dimensions	
L	6mm +/-0.3mm
W	3.2mm +/-0.3mm
Н	2.5mm +/-0.3mm
T	0.13mm REF
S	1.3mm +/-0.3mm
F	2.2mm +/-0.1mm
A	2.9mm MIN
В	0.5mm +/-0.15mm
E	2.4mm REF
G	2.8mm REF
Р	0.9mm REF
R	1mm REF
X	0.1mm +/-0.1mm REF

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Packaging Specifications	
Packaging	T&R, 330mm
Packaging Quantity	3000

Specifications	
Capacitance	1.5 uF
Tolerance	20%
Voltage DC	50 VDC (85C), 33.5 VDC (125C)
Temperature Range	-55/+125°C
Rated Temperature	85°C
Dissipation Factor	6% 120Hz 25C
Failure Rate	N/A
ESR	4 Ohms (100kHz 25C)
Ripple Current	166 mA (rms, 100kHz 25C), 149.4 mA (rms, 85C), 66.4 mA (rms, 125C)
Leakage Current	0.8 uA (5min 25°C)

Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute - and we specifically disclaim - any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

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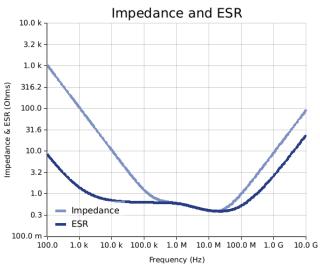


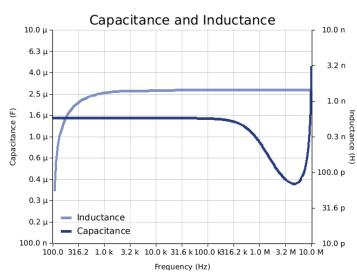


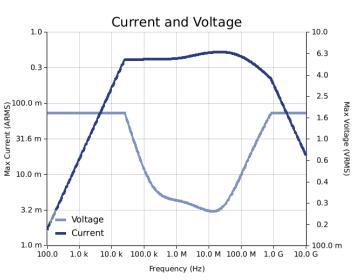
T491, Tantalum, MnO2 Tantalum, Commercial Grade, 1.5 uF, 20%, 50 VDC, SMD, MnO2, Molded, 4 Ohms, 6032, 2.8 mm, 1.3 mm

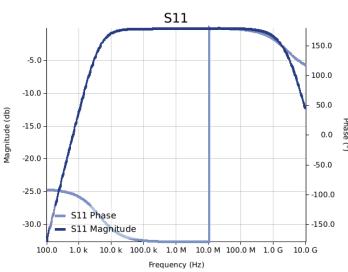
## **Simulations**

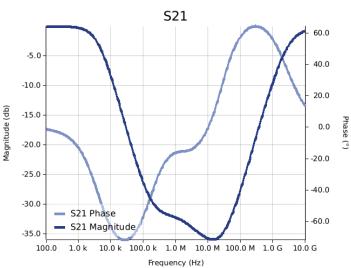
For the complete simulation environment please visit Y-SIM.











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## T491C155M050AT7280

T491, Tantalum, MnO2 Tantalum, Commercial Grade, 1.5 uF, 20%, 50 VDC, SMD, MnO2, Molded, 4 Ohms, 6032, 2.8 mm, 1.3 mm

## These are simulations.

This is not a specification!

The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

The responses shown do not represent a specified or implied maximum capability of the device for all applications.

- The ESR used for ripple "Ripple Current/Voltage vs. Frequency" plots is the ESR at ambient temperature.

- The ESR in the "Temperature Rise vs. Ripple Current" plots is the ESR at ambient temperature. The ESR in the "Temperature Rise vs. Ripple Current" plots is adjusted to each incremental temperature rise before the power and ripple current is calculated. The effects shown herein are based on measured data from a multiple part sample of the parts in question. Ripple capability of this device will be factored by thermal resistance (Rth) created by circuit traces (addi affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

  The peak voltages generated in the "Temperature Rise vs. Combined Ripple Currents" plot are calculated for each frequency and are not combined with voltages
- generated at any other harmonics.

   Please consult with the catalog or field applications engineer for maximum capability of the device in specific applications.

All product information and data (collectively, the "Information") are subject to change without notice.

KEMET K-SIM is designed to simulate behavior of components with respect to frequency, ambient temperature, and DC bias levels. The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation effects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

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If you have any questions please contact K-SIM.

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